



November 2007

## FDJ129P

### P-Channel -2.5 Vgs Specified PowerTrench® MOSFET

#### General Description

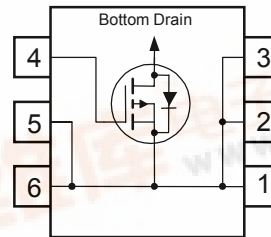
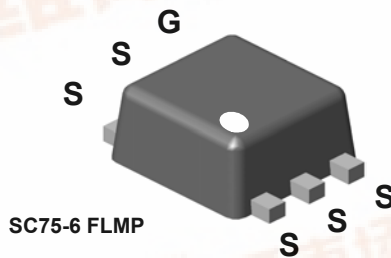
This P-Channel -2.5V specified MOSFET uses Fairchild's advanced low voltage PowerTrench process. It has been optimized for battery power management applications.

#### Applications

- Battery management
- Load switch

#### Features

- -4.2 A, -20 V.  $R_{DS(ON)} = 70 \text{ m}\Omega @ V_{GS} = -4.5 \text{ V}$   
 $R_{DS(ON)} = 120 \text{ m}\Omega @ V_{GS} = -2.5 \text{ V}$
- Low gate charge
- High performance trench technology for extremely low  $R_{DS(ON)}$
- Compact industry standard SC75-6 surface mount package
- RoHS Compliant



#### Absolute Maximum Ratings $T_A = 25^\circ\text{C}$ unless otherwise noted

Symbol	Parameter	Ratings	Units
$V_{DSS}$	Drain-Source Voltage	-20	V
$V_{GSS}$	Gate-Source Voltage	$\pm 12$	V
$I_D$	Drain Current – Continuous (Note 1a)	-4.2	A
	– Pulsed	-16	
$P_D$	Power Dissipation for Single Operation (Note 1a)	1.6	W
$T_J, T_{STG}$	Operating and Storage Junction Temperature Range	-55 to +150	$^\circ\text{C}$

#### Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient (Note 1a)	77	$^\circ\text{C/W}$
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#### Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
.A	FDJ129P	7"	8mm	3000 units

**Electrical Characteristics** $T_A = 25^\circ\text{C}$  unless otherwise noted

Symbol	Parameter	Test Conditions	Min	Typ	Max	Units
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**Off Characteristics**

$BV_{DSS}$	Drain–Source Breakdown Voltage	$V_{GS} = 0\text{ V}, I_D = -250\text{ }\mu\text{A}$	-20			V
$\frac{\Delta BV_{DSS}}{\Delta T_J}$	Breakdown Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$		-18		mV/ $^\circ\text{C}$
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = -16\text{ V}, V_{GS} = 0\text{ V}$			-1	$\mu\text{A}$
$I_{GSSF}$	Gate–Body Leakage, Forward	$V_{GS} = 12\text{ V}, V_{DS} = 0\text{ V}$			100	nA
$I_{GSSR}$	Gate–Body Leakage, Reverse	$V_{GS} = -12\text{ V}, V_{DS} = 0\text{ V}$			-100	nA

**On Characteristics (Note 2)**

$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_D = -250\text{ }\mu\text{A}$	-0.6	-1.1	-1.5	V
$\frac{\Delta V_{GS(th)}}{\Delta T_J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250\text{ }\mu\text{A}$ , Referenced to $25^\circ\text{C}$		3		mV/ $^\circ\text{C}$
$R_{DS(on)}$	Static Drain–Source On–Resistance	$V_{GS} = -4.5\text{ V}, I_D = -4.2\text{ A}$ $V_{GS} = -2.5\text{ V}, I_D = -3.3\text{ A}$ $V_{GS} = -4.5\text{ V}, I_D = -4.2\text{ A}, T_J = 125^\circ\text{C}$		54 91 72	70 120 100	m $\Omega$
$I_{D(on)}$	On–State Drain Current	$V_{GS} = -4.5\text{ V}, V_{DS} = -5\text{ V}$	-8			A
$g_{FS}$	Forward Transconductance	$V_{DS} = -5\text{ V}, I_D = -4.2\text{ A}$		11		S

**Dynamic Characteristics**

$C_{iss}$	Input Capacitance	$V_{DS} = -10\text{ V}, V_{GS} = 0\text{ V},$ $f = 1.0\text{ MHz}$		585	780	pF
$C_{oss}$	Output Capacitance			124	170	pF
$C_{rss}$	Reverse Transfer Capacitance			61	95	pF

**Switching Characteristics (Note 2)**

$t_{d(on)}$	Turn–On Delay Time	$V_{DD} = -10\text{ V}, I_D = -1\text{ A},$ $V_{GS} = -4.5\text{ V}, R_{GEN} = 6\text{ }\Omega$		10	20	ns
$t_r$	Turn–On Rise Time			9	18	ns
$t_{d(off)}$	Turn–Off Delay Time			17	30	ns
$t_f$	Turn–Off Fall Time			10	20	ns
$Q_g$	Total Gate Charge	$V_{DS} = -10\text{ V}, I_D = -4.2\text{ A},$ $V_{GS} = -4.5\text{ V}$		4	6	nC
$Q_{gs}$	Gate–Source Charge			1.1		nC
$Q_{gd}$	Gate–Drain Charge			1.2		nC

**Drain–Source Diode Characteristics and Maximum Ratings**

$V_{SD}$	Drain–Source Diode Forward Voltage	$V_{GS} = 0\text{ V}, I_S = -1.5\text{ A}$ (Note 2)		-0.7	-1.2	V
$t_{rr}$	Diode Reverse Recovery Time	$I_F = -4.2\text{ A},$		16		nS
$Q_{rr}$	Diode Reverse Recovery Charge	$dI_F/dt = 100\text{ A}/\mu\text{s}$		13		nC

**Notes:**

1.  $R_{\theta JA}$  is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins.  $R_{\theta JC}$  is guaranteed by design while  $R_{\theta CA}$  is determined by the user's board design.



- a)  $77^\circ\text{C}/\text{W}$  when mounted on a  $1\text{ in}^2$  pad of 2 oz copper.



- b)  $110^\circ\text{C}/\text{W}$  when mounted on a minimum pad of 2 oz copper.

Scale 1 : 1 on letter size paper

2. Pulse Test: Pulse Width < 300 $\mu\text{s}$ , Duty Cycle < 2.0%

## Typical Characteristics

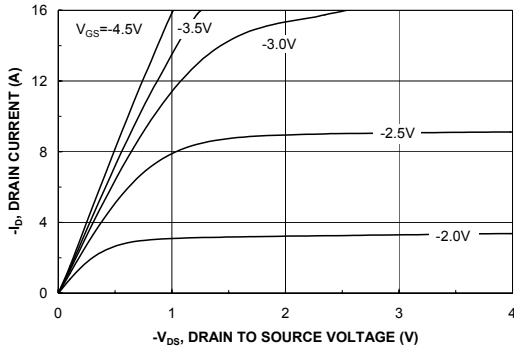


Figure 1. On-Region Characteristics.

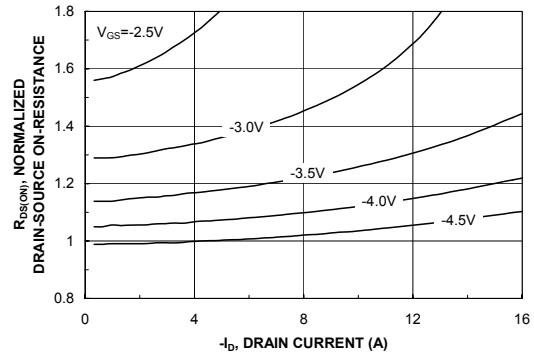


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

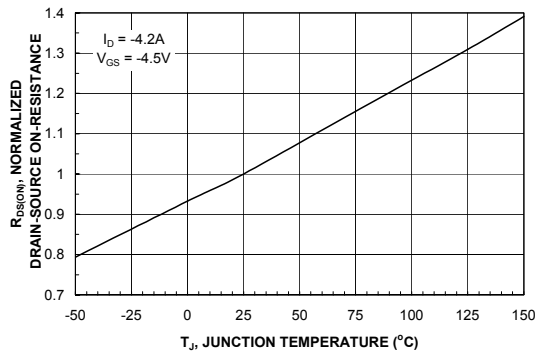


Figure 3. On-Resistance Variation with Temperature.

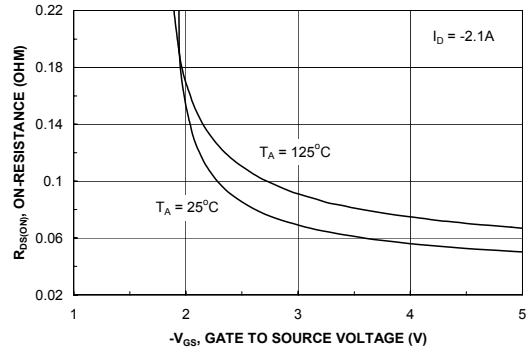


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

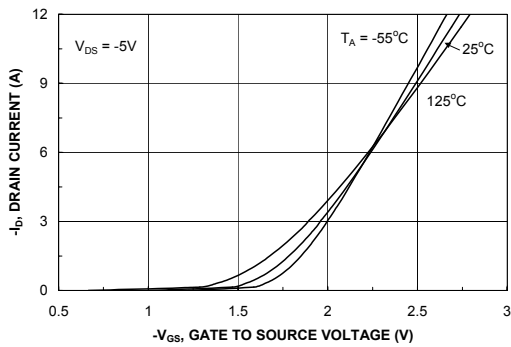


Figure 5. Transfer Characteristics.

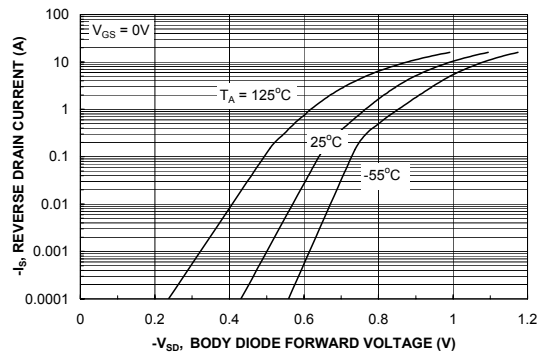


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

## Typical Characteristics

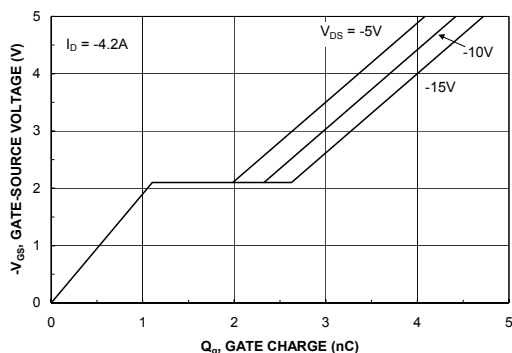


Figure 7. Gate Charge Characteristics.

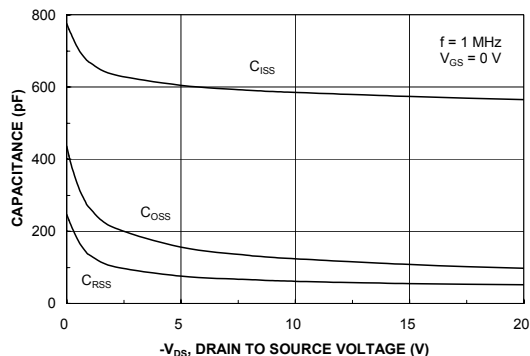


Figure 8. Capacitance Characteristics.

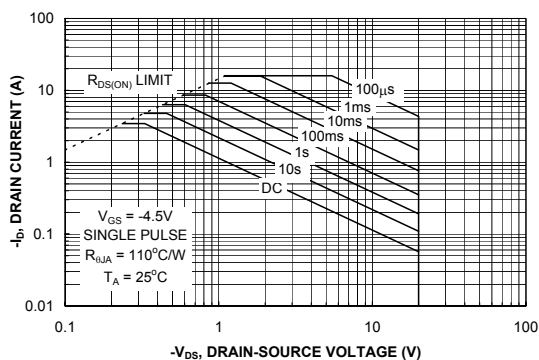


Figure 9. Maximum Safe Operating Area.

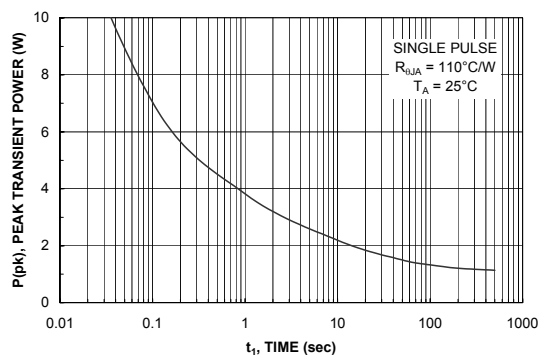


Figure 10. Single Pulse Maximum Power Dissipation.

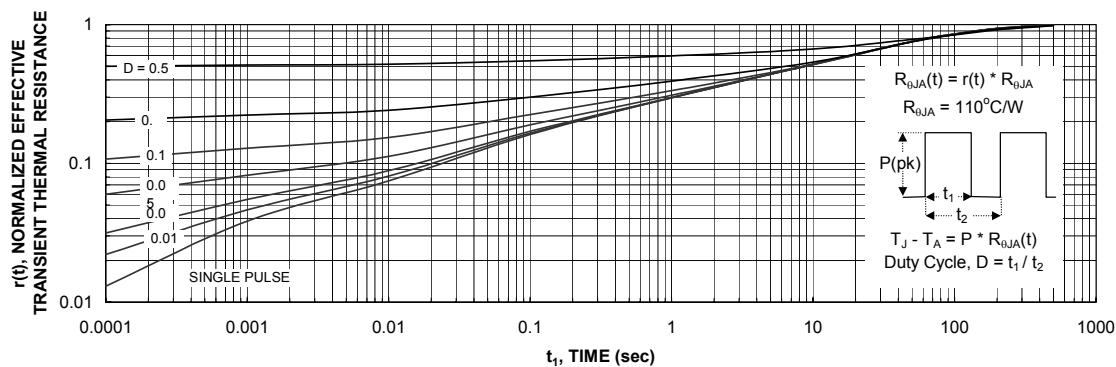



Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1b.  
Transient thermal response will change depending on the circuit board design.

- NOTES: UNLESS OTHERWISE SPECIFIED
- A) NO PACKAGE STANDARD REFERENCE  
AS OF JULY 13, 2000.
  - B) ALL DIMENSIONS ARE IN MILLIMETERS.
  - C) DIMENSIONS DO NOT INCLUDE BURRS  
OR MOLD FLASH.

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